

Notice of References Cited		Application/Control No. 10/562,803	Applicant(s)/Patent Under Reexamination GAO ET AL.	
		Examiner Narayan K. Bhat	Art Unit 1634	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,567,809	10-1996	Apple et al.	536/24.3
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.